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this is abstract

I. INTRODUCTION

this is main.

II. METHOD

An ADTL082J was used as the Op-Amp, and IRF1010E was used for the n-channel MOSFETs. The $I - V$ characteristics of the MOSFETs were measured prior to the experimental process, in order to obtain a gating voltage and the effective resistance when the MOSFET was open. The negative resistor was designed and measured with the circuit as in Fig. , and the current was measured via a resistor in series in the negative resistor(R). The output voltage of the Op-Amp was also measured to compensate the saturation effects of the real world Op-Amp.

III. RESULT

A. Negative Resistance

Fig 1

B. Tuning Differential Resistance Slopes

Fig 2

C. Effect of Op-Amp Supply Voltage

Fig 3

D. Hysteresis Region

Fig 4

IV. CONCLUSION

Appendix A: MOSFET $I - V$ Characteristics

Appendix B: Derivation of the theoretical $I - V$ Characteristics of the Negative Resistor

a. Op-Amp

For the

b. Op-Amp and MOSFETs

The unsaturated region of the negative resistor using enabling MOSFETs is identical to the unsaturated region of the negative resistor without the MOSFETs, since all of the MOSFETs do not flow current. We derive a theoretical description of the differential resistance slopes for the region where the MOSFETs are opened.

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